

<b>Notice of References Cited</b>	Application/Control No. 09/997,079	Applicant(s)/Patent Under Reexamination TANIGUCHI ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2001/0020992	09-2001	Takeda et al.	349/130
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
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	J	US-			
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	L	US-			
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**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2-191914	07-1990	Japan	Ito	
	O					
	P					
	Q					
	R					
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**NON-PATENT DOCUMENTS**

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